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Application/Control No.	Applicant(s)/Patent under Reexamination
10/721,093	SHIN ET AL.
Examiner	Art Unit
DAVID VU	2818

SEARCHED				
Class	Subclass	Date	Examiner	
438	239, 244; 253, 254; 387, 396	3/17/2005	DV	
257	301, 303	3/17/2005	DV	
	306	3/17/2005	DV	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
All	Above	3/17/2005	DV	

(INCLUDIN	EARCH NOTES G SEARCH STRATEG	Y)
	DATE	EXMR
EAST	3/17/2005	DV
EAST	3/17/2005	DV